Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/510,602	JEON ET AL.	
Examiner	Art Unit	
Michael Kornakov	1746	

	SEAD	CHED	
	JLAN	CITED	
Class	Subclass	Date	Examiner
134	1.2,21,26, 30,31	3/6/2006	MK
438	710,906	3/6/2006	MK
216	59,63,67	3/6/2006	MK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
WEST 2.2 (Pre-Grant, USPAT, JPO,EPO,DERWENT)	3/6/2006	МК
Inventors' and assignee search	3/6/2006	МК
NPL search	3/6/2006	МК